1.8V / 3V SIM Card Power Supply and Level Shifter

The NCN4555 is a level shifter analog circuit designed to translate the voltages between a SIM Card and an external microcontroller or MPU. A built–in LDO–type DC–DC converter makes the NCN4555 useable to drive 1.8 V and 3.0 V SIM card. The device fulfills the ISO7816–3 smart card interface standard as well as GSM 11.11 and related (11.12 and 11.18) and 3G mobile requirements (IMT–2000/3G UICC standard). With the \overline{STOP} pin a low current shutdown mode can be activated making the battery life longer. The Card power supply voltage (SIM_VCC) is selected using a single pin (MOD_VCC).

Features

- Supports 1.8 V or 3.0 V Operating SIM Card
- The LDO is able to Supply More than 50 mA under 1.8 V and 3.0 V
- Built-in Pullup Resistor for I/O Pin in Both Directions
- All Pins are Fully ESD Protected According to ISO-7816
 Specifications ESD Protection on SIM Pins in Excess of 7 kV (Human Body Model)
- Supports up to More than 5 MHz Clock
- Low-Profile 3x3 QFN-16 Package
- These are Pb-Free Devices*

Typical Applications

- SIM Card Interface Circuit for 2G, 2.5G and 3G Mobile Phones
- Identification Module
- Smart Card Readers
- Wireless PC Cards

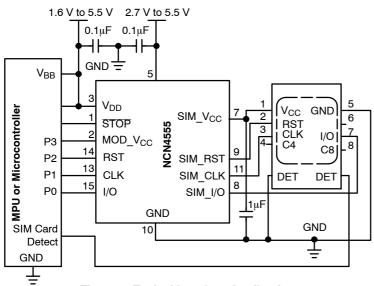


Figure 1. Typical Interface Application



ON Semiconductor®

http://onsemi.com

MARKING DIAGRAM

QFN-16 MN SUFFIX CASE 488AK



A = Assembly Location

= Wafer Lot

Y = Year

W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NCN4555MNG	QFN-16 (Pb-Free)	123 Units / Rail
NCN4555MNR2G	QFN-16 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

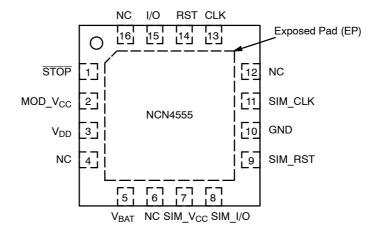


Figure 2. QFN-16 Pinout (Top View)

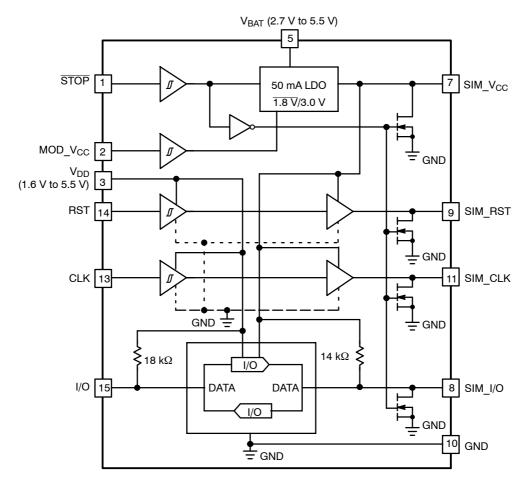


Figure 3. NCN4555 Block Diagram

PIN DESCRIPTIONS

PIN	Name	Туре	Description	
1	STOP	INPUT	Power Down Mode pin: STOP = Low → Low current shutdown mode activated STOP = High → Normal Operation A Low level on this pin resets the SIM interface, switching off the SIM_V _{CC} .	
2	MOD_V _{CC}	INPUT	The signal present on this pin programs the SIM_V _{CC} value: $MOD_V_{CC} = Low \rightarrow SIM_V_{CC} = 1.8 \text{ V} \\ MOD_V_{CC} = High \rightarrow SIM_V_{CC} = 3 \text{ V}$	
3	V _{DD}	POWER	This pin is connected to the system controller power supply. It configures the level shifter input stage to accept the signals coming from the microprocessor. A 0.1 μ F capacitor shall be used to bypass the power supply voltage. When V _{DD} is below 1.1 V typical the SIM_V _{CC} is disabled. The NCN4555 comes into a shutdown mode.	
4	NC		No Connect	
5	V_{BAT}	POWER	DC–DC converter supply input. The input voltage ranges from 2.7V up to 5.5V. This pin has to be bypass by a 0.1 μ F capacitor.	
6	NC		No Connect	
7	SIM_V _{CC}	POWER	This pin is connected to the SIM card power supply pin. An internal LDO converter is programmable by the external MPU to supply either 1.8 V or 3.0 V output voltage. An external 1.0 μF minimum ceramic capacitor recommended must be connected across SIM_V_C_C and GND. During a normal operation, the SIM_V_C_C voltage can be set to 1.8 V followed by a 3.0 V value, or can start directly to any of these two values.	
8	SIM_I/O	INPUT/ OUTPUT	This pin handles the connection to the serial I/O of the card connector. A bidirectional level translator adapts the serial I/O signal between the card and the micro controller. A 14 k Ω (typical) pullup resistor provides a High impedance state for the SIM card I/O link.	
9	SIM_RST	OUTPUT	This pin is connected to the RESET pin of the card connector. A level translator adapts the external Reset (RST) signal to the SIM card.	
10	GND	GROUND	This pin is the GROUND reference for the integrated circuit and associated signals. Care must be taken to avoid voltage spikes when the device operates in a normal operation.	
11	SIM_CLK	OUTPUT	This pin is connected to the CLOCK pin of the card connector. The CLOCK (CLK) signal comes from the external clock generator, the internal level shifter being used to adapt the voltage defined for the SIM $_{\rm VCC}$.	
12	NC		No Connect	
13	CLK	INPUT	The clock signal, coming from the external controller, must have a Duty Cycle within the Min/Max values defined by the specification (typically 50%). The built–in level shifter translates the input signal to the external SIM card CLK input.	
14	RST	INPUT	The RESET signal present at this pin is connected to the SIM card through the internal level shifter which translates the level according to the SIM_V _{CC} programmed value.	
15	I/O	INPUT/ OUTPUT	This pin is connected to an external microcontroller or cellular phone management unit. A bidirectional level translator adapts the serial I/O signal between the smart card and the external controller. A built–in constant 18 k Ω (typical) resistor provides a high impedance state when not activated.	
16	NC		No Connect	

ATTRIBUTES

Characte	Values		
ESD protection HBM, SIM card pins (7, 8, 9, 10 HBM, All other pins (Note 1) MM, SIM card pins (7, 8, 9, 10 MM, All other pins (Note 2) CDM, SIM card pins (7, 8, 9, 10 CDM, All other pins (Note 3)	> 7 kV > 2 kV > 600 V > 200 V > 2 kV > 600 V		
Moisture sensitivity (Note 4) QI	Level 1		
Flammability Rating	UL 94 V-0 @ 0.125 in		
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test			

- 1. Human Body Model, R =1500 Ω , C = 100 pF.
- 2. Machine Model.
- 3. CDM, Charged Device Model.
- 4. For additional information, see Application Note AND8003/D.

MAXIMUM RATINGS (Note 5)

Rating	Symbol	Value	Unit	
LDO Power Supply Voltage	V_{BAT}	-0.5 ≤ V _{BAT} ≤ 6	V	
Power Supply from Microcontroller Side	V _{DD}	$-0.5 \le V_{DD} \le 6$	V	
External Card Power Supply	SIM_V _{CC}	-0.5 ≤ SIM_V _{CC} ≤ 6	V	
Digital Input Pins	V _{in} I _{in}	$\begin{array}{c} -0.5 \leq V_{in} \leq V_{DD} + 0.5 \\ \text{but} < 6.0 \\ \pm 5 \end{array}$	V mA	
Digital Output Pins	V _{out} I _{out}	$-0.5 \le V_{out} \le V_{DD} + 0.5$ but < 6.0 ±10	V mA	
SIM card Output Pins	V _{out} I _{out}	$\begin{array}{l} -0.5 \leq V_{out} \leq SIM_V_{CC} + 0.5 \\ \text{but} < 6.0 \\ \text{15 (internally limited)} \end{array}$	V mA	
QFN-16 Low Profile package Power Dissipation @ T _A = + 85°C Thermal Resistance Junction-to-Air	P _D R _{θJA}	440 90	mW °C/W	
Operating Ambient Temperature Range	T _A	-40 to +85	°C	
Operating Junction Temperature Range	T _J	-40 to +125	°C	
Maximum Junction Temperature	T _{Jmax}	+125	°C	
Storage Temperature Range	T _{stg}	-65 to + 150	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

5. Maximum electrical ratings are defined as those values beyond which damage to the device may occur at $T_A = +25^{\circ}C$

POWER SUPPLY SECTION (-40°C to +85°C)

Pin	Symbol	Rating	Min	Тур	Max	Unit
5	V_{BAT}	Power Supply	2.7		5.5	V
5	I _{VBAT}	Operating current – I _{CC} = 0 mA (Note 6)		22	30	μΑ
5	I _{VBAT_SD}	Shutdown current – STOP= Low (Note 7)			3.0	μΑ
3	V_{DD}	Operating Voltage	1.6		5.5	V
3	I_{VDD}	Operating Current – f _{CLK} = 1 MHz (Note 8)		7.0	12	μΑ
3	I _{VDD_SD}	Shutdown Current – STOP = Low			1.0	μΑ
3	V_{DD}	Undervoltage Lockout	0.6		1.5	V
7	SIM_V _{CC}	$\begin{array}{l} \text{MOD_V}_{\text{CC}} = \text{High, V}_{\text{BAT}} = 3.0 \text{ V, I}_{\text{SIM_VCC}} = 50 \text{ mA} \\ \text{MOD_V}_{\text{CC}} = \text{High, V}_{\text{BAT}} = 3.3 \text{ V to } 5.5 \text{ V, I}_{\text{SIM_VCC}} = 0 \text{ mA to } 50 \text{ mA} \\ \text{MOD_V}_{\text{CC}} = \text{Low, V}_{\text{BAT}} = 2.7 \text{ V to } 5.5 \text{ V, I}_{\text{SIM_VCC}} = 0 \text{ mA to } 50 \text{ mA} \\ \end{array}$	2.8 1.7	2.8 3.0 1.8	3.2 1.9	V V
7	I _{SIM_VCC_SC}	Short –Circuit Current – SIM_V _{CC} shorted to ground , T _A =25°C			175	mA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 6. As long as $V_{BAT} V_{DD} \le 2.5$ V. For $V_{BAT} V_{DD} > 2.5$ V the maximum value increases up to 35 μ A (typical being in the +25 μ A range). 7. As long as $V_{BAT} V_{DD} \le 2.5$ V.
- 8. Guaranteed by design over the operating temperature range specified.

DIGITAL INPUT/OUTPUT SECTION CLOCK, RESET, I/O, STOP, MOD_VCC

Pin	Symbol	Rating		Тур	Max	Unit
1,2, 13, 14, 15	V _{in}	Input Voltage Range (STOP, MOD_V _{CC} , RST, CLK, I/O)	0		V_{DD}	٧
,	I _{IH} & I _{IL}	Input Current (STOP, MOD_V _{CC} , RST, CLK)	-100		100	nA
13, 14	V _{IH} V _{IL}	High Level Input Voltage (RST, CLK) Low Level Input Voltage (RST, CLK)	0.7 * V _{DD} (Note 9)		V _{DD} 0.4	V V
1, 2	V_{IH}	High Level Input Voltage (STOP, MOD_V _{CC})	0.7 * V _{DD} (Note 9)		V_{DD}	V
	V_{IL}	Low Level Input Voltage (STOP, MOD_V _{CC})	0		0.4	V
15	V _{OH_I/O} V _{OL_I/O} I _{IH} I _{IL}	High Level Output Voltage (SIM_I/O = SIM_V _{CC} , I _{OH_I/O} = -20 μ A) Low Level Output Voltage (SIM_I/O = 0 V, I _{OH_I/O} = $\overline{200}$ μ A) High Level Input Current (I/O) Low Level Input Current (I/O)	0.7 * V _{DD} 0 -20		V _{DD} 0.4 20 1.0	V V μA mA
15	R _{pu_I/O}	I/0 Pullup Resistor	12	18	24	kΩ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

9. If 1.6 V \leq V_{DD} \leq 1.8 V then V_{IHmin} = 1.26 V.

SIM INTERFACE SECTION (Note 10)

Pin	Symbol	Rating	Min	Тур	Max	Unit
9	SIM_RST	$\begin{split} SIM_V_{CC} = +3.0 \text{ V (MOD_V}_{CC} = \text{High)} \\ \text{Output RESET V}_{OH} @ I_{\text{sim_rst}} = -20 \mu\text{A} \\ \text{Output RESET V}_{OL} @ I_{\text{sim_rst}} = +200 \mu\text{A} \\ \text{Output RESET Rise Time @ Cout} = 30 \text{ pF} \\ \text{Output RESET Fall Time @ Cout} = 30 \text{ pF} \end{split}$	0.9 * SIM_V _{CC}		SIM_V _{CC} 0.4 1	> րs րs
		$\begin{array}{l} SIM_V_{CC} = +1.8 \ V \ (MOD_V_{CC} = Low) \\ Output \ RESET \ V_{OH} \ @ \ I_{sim_rst} = -20 \ \mu A \\ Output \ RESET \ V_{OL} \ @ \ I_{sim_rst} = +200 \ \mu A \\ Output \ RESET \ Rise \ Time \ @ \ Cout = 30 \ pF \\ Output \ RESET \ Fall \ Time \ @ \ Cout = 30 \ pF \end{array}$	0.9 * SIM_V _{CC} 0		SIM_V _{CC} 0.4 1 1	V V μs μs
11	SIM_CLK	$SIM_V_{CC} = +3.0 \text{ V (MOD}_V_{CC} = \text{High)} \\ \text{Output Duty Cycle} \\ \text{Max Output Frequency} \\ \text{Output V}_{OH} @ I_{\text{sim_clk}} = -20 \ \mu\text{A} \\ \text{Output V}_{OL} @ I_{\text{sim_clk}} = +200 \ \mu\text{A} \\ \text{Output SIM_CLK Rise Time @ Cout} = 30 \ \text{pF} \\ \text{Output SIM_CLK Fall Time} \\ \text{Output SIM_CLK Fall Time @ Cout} = 30 \ \text{pF} \\ \text{Output SIM_CLK Fall Time} \\ Output SIM_CL$	40 5 0.9 * SIM_V _{CC} 0		60 SIM_V _{CC} 0.4 18 18	% MHz V V ns
		$SIM_V_{CC} = +1.8 \ V \ (MOD_V_{CC} = Low)$ Output Duty Cycle Max Output Frequency Output $V_{OH} @ I_{sim_clk} = -20 \ \mu A$ Output $V_{OL} @ I_{sim_clk} = +200 \ \mu A$ Output $SIM_CLK \ Rise \ Time @ \ Cout = 30 \ pF$ Output $SIM_CLK \ Fall \ Time @ \ Cout = 30 \ pF$	40 5 0.9 * SIM_V _{CC} 0		60 SIM_V _{CC} 0.4 18 18	% MHz V V ns
8	SIM_I/O	$\begin{array}{l} SIM_V_{CC} = +3.0 \text{ V (MOD_V_{CC} = High)} \\ Output \text{ V}_{OH} @ \text{ I}_{SIM_IO} = -20 \mu\text{A, V}_{I/O} = \text{V}_{DD} \\ Output \text{ V}_{OL} @ \text{ I}_{SIM_IO} = +1 \text{ mA, V}_{I/O} = 0 \text{ V} \\ SIM_I/O \text{ Rise Time } @ \text{ C}_{out} = 30 \text{ pF} \\ SIM_I/O \text{ Fall Time } @ \text{ C}_{out} = 30 \text{ pF} \end{array}$	0.8 * SIM_V _{CC}		SIM_V _{CC} 0.4 1	V γ μs
		$\begin{split} &\text{SIM_V}_{CC} = +1.8 \text{ V (MOD_V}_{CC} = \text{High)} \\ &\text{Output V}_{OH} \textcircled{@} \text{ I}_{\text{SIM_IO}} = -20 \text{ µA, V}_{\text{I/O}} = \text{V}_{DD} \\ &\text{Output V}_{OL} \textcircled{@} \text{ I}_{\text{SIM_IO}} = +1.0 \text{ mA, V}_{\text{I/O}} = 0 \text{ V} \\ &\text{SIM_I/O Rise Time } \textcircled{@} \text{ C}_{\text{out}} = 30 \text{ pF} \\ &\text{SIM_I/O Fall Time } \textcircled{@} \text{ C}_{\text{out}} = 30 \text{ pF} \end{split}$	0.8 * SIM_V _{CC} 0		SIM_V _{CC} 0.3 1 1	V V μs μs
8	R _{pu_SIM_I/O}	Card I/O Pullup Resistor	10	14	18	kΩ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

^{10.} All the dynamic specifications (AC specifications) are guaranteed by design over the operating temperature range.

TYPICAL CHARACTERISTICS

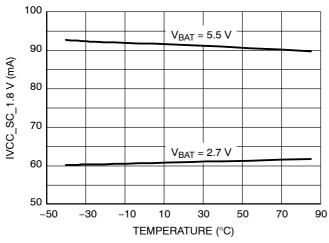


Figure 4. Short Circuit Current IV $_{CC}$ SC vs Temperature at SIM $_{VCC}$ = 1.8 V (MOD $_{VCC}$ = LOW)

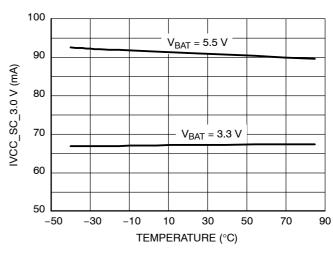


Figure 5. Short Circuit Current IV $_{CC}$ SC vs Temperature at SIM $_{VCC}$ = 3.0 V (MOD $_{VCC}$ = HIGH)

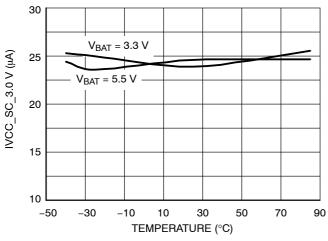


Figure 6. I_{BAT} vs temperature at 3.0 V

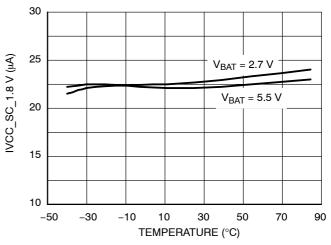


Figure 7. IV_{BAT} vs Temperature at 1.8 V

APPLICATION INFORMATION

CARD SUPPLY CONVERTER

The NCN4555 interface DC-DC converter is a Low Dropout Voltage Regulator capable of suppling a current in excess of 50 mA under 1.8 V or 3.0 V. This device features a very low quiescent current typically lower than 25 μA (Figure 6 and 7). MOD_V_{CC} is a select input allowing a logic level signal to select a regulated voltage of 1.8 V (MOD V_{CC} = LOW) or 3.0 V (MOD V_{CC} = HIGH). Additionally, the NCN4555 has a shutdown input allowing it to turn off or turn on the regulator output. The shutdown mode power consumption is typically in the range of a few tens of nA (30 nA Typical). Figure 8 shows a simplified view of the NCN4555 voltage regulator. The SIM V_{CC} output is internally current limited and protected against short circuits. The short-circuit current IV_{CC} is constant over the temperature and SIM V_{CC}. It varies with V_{BAT} typically in the range of 60 mA to 90 mA (Figure 4 and 5).

In order to guarantee a stable and satisfying operating of the LDO the SIM_V_CC output will be connected to a 1.0 μF bypass ceramic capacitor to the ground. At the input, V_{BAT} will be bypassed to the ground with a 0.1 μF ceramic capacitor.

LEVEL SHIFTERS

The level shifters accommodate the voltage difference that might exist between the microcontroller and the smart card. The RESET and CLOCK level shifters are monodirectional and feature both the same architecture.

The bidirectional I/O line provides a way to automatically adapt the voltage difference between the MCU and the SIM card in both directions. In addition with the pullup resistor, an active pullup circuit (Figure 8, Q1 and Q2) provides a fast charge of the stray capacitance, yielding a rise time fully within the ISO7816 specifications.

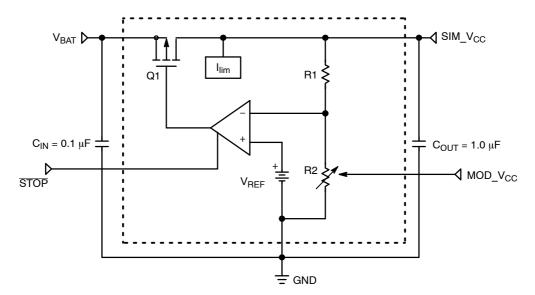


Figure 8. Simplified Block Diagram of the LDO Voltage Regulator

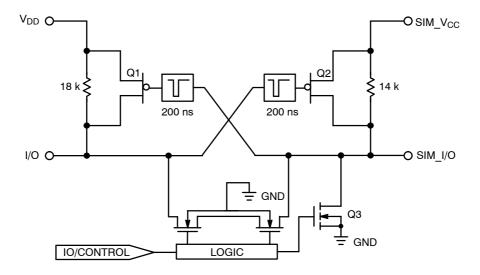


Figure 9. Basic I/O Line Interface

The typical waveform provided in Figure 10 shows how the accelerator operates. During the first 200 ns (typical), the slope of the rise time is solely a function of the pullup resistor associated with the stray capacitance. During this period, the PMOS devices are not activated since the input voltage is below their $V_{\rm gs}$ threshold. When the input slope crosses the $V_{\rm gsth}$, the opposite one shot is activated, providing a low impedance to charge the capacitance, thus increasing the rise time as depicted in Figure 10. The same mechanism applies for the opposite side of the line to make sure the system is optimum.

INPUT SCHMITT TRIGGERS

All the Logic input pins (excepted I/O and SIM_I/O, See Figure 3) have built-in Schmitt trigger circuits to prevent the NCN4555 against uncontrolled operation. The typical dynamic characteristics of the related pins are depicted Figure 11.

The output signal is guaranteed to go High when the input voltage is above $0.7~x~V_{DD}$, and will go Low when the input voltage is below 0.4~V.

SHUTDOWN OPERATING

In order to save power or for other purpose required by the application it is possible to put the NCN4555 in a shutdown mode by setting Low the pin \overline{STOP} . On the other hand the device enters automatically in a shutdown mode when V_{DD} becomes lower than 1.1 V typically.

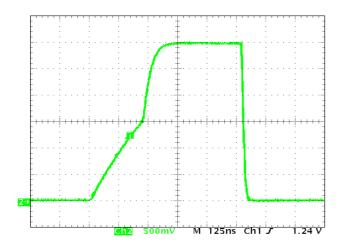


Figure 10. SIM_IO Typical Rise and Fall Times with Stray Capacitance > 30 pF (33 pF Capacitor Connected on the Board)

ESD PROTECTION

The NCN4555 SIM interface features an HBM ESD voltage protection in excess of 7 kV for all the SIM pins (SIM_IO, SIM_CLK, SIM_RST, SIM_V_{CC} and GND). All the other pins (microcontroller side) sustain at least 2 kV. These values are guaranteed for the device in its full integrity without considering the external capacitors added to the circuit for a proper operating. Consequently in the operating conditions it is able to sustain much more than 7 kV on its SIM pins making it perfectly protected against electrostatic discharge well over the HBM ESD voltages required by the ISO7816 standard (4 kV).

PRINTED CIRCUIT BOARD LAYOUT

Careful layout routing will be applied to achieve a good and efficient operating of the device in its mobile or portable environment and fully exploit its performance.

The bypass capacitors have to be connected as close as possible to the device pins (SIM_ V_{CC} , V_{DD} or V_{BAT}) in order to reduce as much as possible parasitic behaviors (ripple and noise). It is recommended to use ceramic capacitors.

The exposed pad of the QFN-16 package will be connected to the ground as well as the unconnected pins (NC). A relatively large ground plane is recommended.

Figures 12 and 13 shows an example of PCB device implementation in an evaluation environment.

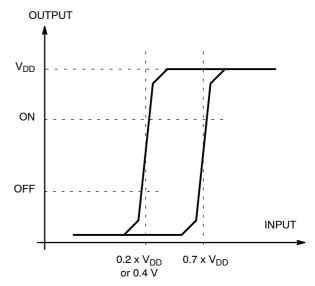


Figure 11. Typical Schmitt Trigger Characteristics

EVALUATION BOARD AND PCB GUIDELINES

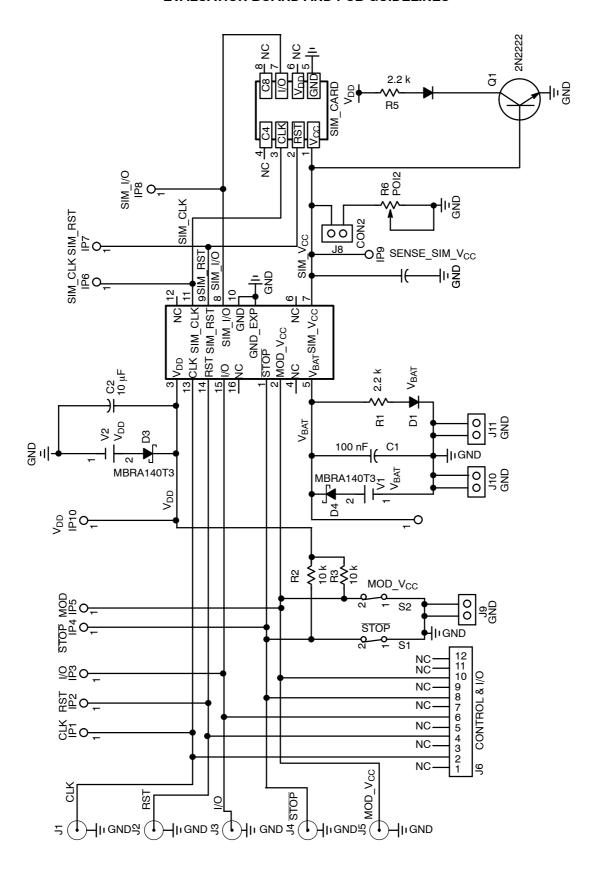
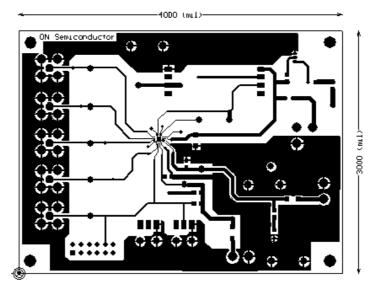


Figure 12. NCN4555 engineering test board schematic diagram

EVALUATION BOARD AND PCB GUIDELINES



Top Layer

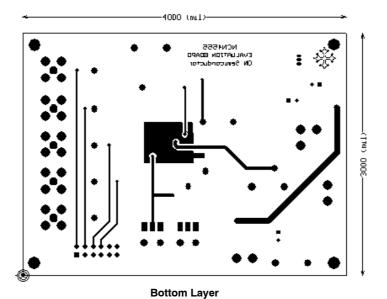
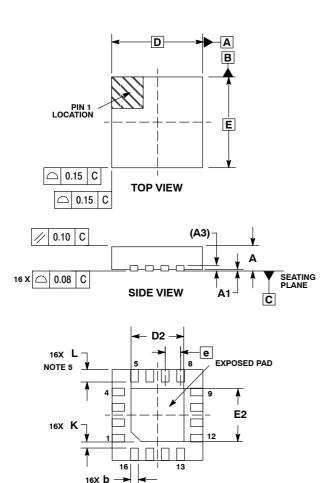


Figure 13. NCN4555 Printed Circuit Board Layout (Engineering board)

PACKAGE DIMENSIONS

QFN16 3x3x0.75mm, 0.5P CASE 488AK-01 ISSUE O



BOTTOM VIEW

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION IS APPLIES TO PLATED
 TERMINAL AND IS MEASURED BETWEEN
 0.25 AND 0.30 MM FROM TERMINAL.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- 5. L_{max} CONDITION CAN NOT VIOLATE 0.2 MM SPACING BETWEEN LEAD TIP AND FLAG.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
A3	0.20	REF		
b	0.18	0.30		
D	3.00 BSC			
D2	1.65	1.85		
E	3.00	BSC		
E2	1.65	1.85		
е	0.50 BSC			
K	0.20			
L	0.30	0.50		

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

0.10

 \oplus

CAB

0.05 C

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlitt@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81–3–5773–3850 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative



Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию.

Осуществляем поставки продукции под контролем ВП МО РФ на предприятия военно-промышленного комплекса России, а также работаем в рамках 275 ФЗ с открытием отдельных счетов в уполномоченном банке. Система менеджмента качества компании соответствует требованиям ГОСТ ISO 9001.

Минимальные сроки поставки, гибкие цены, неограниченный ассортимент и индивидуальный подход к клиентам являются основой для выстраивания долгосрочного и эффективного сотрудничества с предприятиями радиоэлектронной промышленности, предприятиями ВПК и научноисследовательскими институтами России.

С нами вы становитесь еще успешнее!

Наши контакты:

Телефон: +7 812 627 14 35

Электронная почта: sales@st-electron.ru

Адрес: 198099, Санкт-Петербург,

Промышленная ул, дом № 19, литера Н,

помещение 100-Н Офис 331